

HiRel NPN Silicon RF Transistor

HiRel Discrete and Microwave Semiconductor

- For low noise, high-gain amplifiers up to 2 GHz
- For linear broadband amplifiers
- Hermetically sealed microwave package
- *f*_T = 8 GHz

F = 2.3 dB at 2 GHz

• **esa** Space Qualified

ESA/SCC Detail Spec. No.: 5611/006

Type Variant No. 06

ESD: Electrostatic discharge sensitive device, observe handling precaution!

Туре	Marking		Pin Configuration Package					
BFY193 (ql)	-	1=C	2=E	3=B	4=E	-	-	MICRO-X1

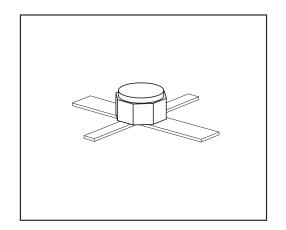
(ql) Testing level: P: Professional testing

H: High Rel quality S: Space quality ES: ESA qualified

Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V _{CEO}	12	V
Collector-emitter voltage, $V_{BE} = 0$	V _{CES}	20	
Collector-base voltage	V_{CBO}	20	
Emitter-base voltage	V _{EBO}	2	
Collector current	I _C	80	mA
Base current	l _B	10 ¹⁾	
Total power dissipation	P_{tot}	580	mW
$T_{\rm S} \le 104^{\circ}{\rm C}^{2)3}$			
Junction temperature	$\mid T_{i} \mid$	200	°C
Operating temperature range	T_{op}	-65 200	°C
Storage temperature	T _{stg}	-65 200	°C

¹The maximum permissible base current for VFBE measurements is 30mA (spotmeasurement duration < 1s)



²At $T_S = 104$ °C. For $T_S > 104$ °C derating is required

 $^{{}^3}T_{\rm S}$ is measured on the collector lead at the soldering point to the pcb



Thermal Resistance

Parameter	Symbol	Value	Unit
Junction - soldering point ¹⁾	R_{thJS}	< 165	K/W

Electrical Characteristics at $T_A = 25$ °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics	•		•	•	•
Base-emitter forward voltage	V_{FBE}	-	-	1	V
$I_{\rm E} = 30 \text{ mA}, I_{\rm C} = 0$					
Collector-emitter cutoff current	/ _{CEX}	-	-	600	μΑ
$V_{CE} = 12 \text{ V}, I_{B} = 0.5 \mu\text{A}^{2)}$					
Collector -base cutoff current	I _{CBO}				μΑ
$V_{\rm CB} = 20 \text{ V}, I_{\rm E} = 0$		-	-	100	
$V_{CB} = 10 \text{ V}, I_{E} = 0$		-	-	0.05	
Emitter-base cutoff current	/ _{EBO}				
$V_{\rm EB} = 2 \text{ V}, I_{\rm C} = 0$		-	-	25	
$V_{\text{EB}} = 1 \text{ V}, I_{\text{C}} = 0$		-	-	0.5	
DC current gain	h _{FE}	50	100	175	-
$I_{\rm C}$ = 30 mA, $V_{\rm CE}$ = 8 V					
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 $^{^{1}}T_{\mathrm{S}}$ is measured on the collector lead at the soldering point to the pcb

 $^{^{2}}$ This test assures $V_{(BR)CE0} > 12V$



Electrical Characteristics at $T_A = 25$ °C, unless otherwise specified Unit Symbol **Values Parameter** min. typ. max. AC Characteristics (verified by random sampling) GHz Transition frequency fΤ $I_{\rm C} = 40$ mA, $V_{\rm CE} = 5$ V, f = 500 MHz 6.5 7.5 $I_{\rm C} = 50 \text{ mA}, \ V_{\rm CE} = 8 \text{ V}, \ f = 500 \text{ MHz}$ 8 Collector-base capacitance C_{cb} 0.56 0.75 pF $V_{CB} = 10 \text{ V}, \ V_{BE} = v_{be} = 0, \ f = 1 \text{ MHz}$ Collector emitter capacitance 0.34 C_{ce} $V_{CE} = 10 \text{ V}, V_{BE} = V_{be} = 0, f = 1 \text{ MHz}$ C_{eb} 2.4 Emitter-base capacitance 1.9 $V_{\text{EB}} = 0.5 \text{ V}, \ V_{\text{CB}} = v_{\text{cb}} = 0, \ f = 1 \text{ MHz}$ Noise figure F 2.3 2.9 dB $I_{\rm C} = 15 \text{ mA}, \ V_{\rm CE} = 5 \text{ V}, \ Z_{\rm S} = Z_{\rm Sopt},$ f = 2 GHzPower gain¹⁾ G_{ma} 12.5 13.5 $I_{\rm C} = 40 \text{ mA}, V_{\rm CE} = 5 \text{ V}, Z_{\rm S} = Z_{\rm Sopt}$ $Z_L = Z_{Lopt}$, f = 2 GHzTransducer gain $|S_{21e}|^2$ 8 9 dB $I_{\rm C} = 40 \text{ mA}, \ V_{\rm CE} = 5 \text{ V}, \ Z_{\rm S} = Z_{\rm L} = 50 \ \Omega$ f = 2 GHzOutput power P_{OUT} 16.5 17.5 dBm

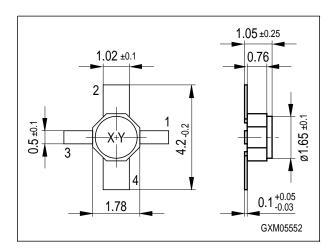
 $I_{\rm C} = 50$ mA, $V_{\rm CE} = 5$ V, $P_{\rm IN} = 10$ dBm,

 $Z_{S} = Z_{L} = 50 \Omega$, f = 2 GHz

 $^{{}^{1}}G_{ma} = |S_{21e} / S_{12e}| (k-(k^{2}-1)^{1/2}), G_{ms} = |S_{21e} / S_{12e}|$



Micro-X1 Package





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